PBSS5130PAP 30 V, 1 A PNP/PNP low VCEsat (BISS) transistor12 December 2012Product

Product data sheet

1. **General description**

PNP/PNP low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a leadless medium power DFN2020-6 (SOT1118) Surface-Mounted Device (SMD) plastic package.

NPN/PNP complement: PBSS4130PANP. NPN/NPN complement: PBSS4130PAN.

Features and benefits 2.

- Very low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High collector current gain h_{FE} at high I_C
- Reduced Printed-Circuit Board (PCB) requirements •
- High energy efficiency due to less heat generation
- AEC-Q101 qualified

Applications 3.

- Load switch
- Battery-driven devices •
- Power management •
- Charging circuits
- Power switches (e.g. motors, fans)

Quick reference data 4.

Table 1. Quick reference data									
Symbol	Parameter	Conditions		Min	Тур	Мах	Unit		
Per transistor	Per transistor								
V _{CEO}	collector-emitter voltage	open base		-	-	-30	V		
I _C	collector current			-	-	-1	А		
I _{CM}	peak collector current	single pulse; t _p ≤ 1 ms		-	-	-2	А		
Per transistor									
R _{CEsat}	collector-emitter saturation resistance	I_{C} = -1 A; I_{B} = -0.1 A; pulsed; t_{p} ≤ 300 µs; δ ≤ 0.02 ; T_{amb} = 25 °C		-	-	250	mΩ		





30 V, 1 A PNP/PNP low VCEsat (BISS) transistor

5. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	E1	emitter TR1	6 5 4	C1 B2 E2
2	B1	base TR1		
3	C2	collector TR2	7 8	
4	E2	emitter TR2		
5	B2	base TR2		E1 B1 C2
6	C1	collector TR1	Transparent top view DFN2020-6 (SOT1118)	sym138
7	C1	collector TR1	2	
8	C2	collector TR2		

6. Ordering information

Table 3. Ordering information							
Type number	Package	ackage					
	Name	Description	Version				
PBSS5130PAP	DFN2020-6	plastic thermal enhanced ultra thin small outline package; no leads; 6 terminals; body $2 \times 2 \times 0.65$ mm	SOT1118				

7. Marking

Table 4. Marking codes	
Type number	Marking code
PBSS5130PAP	2E

8. Limiting values

Table 5.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Мах	Unit			
Per transistor									
V _{CBO}	collector-base voltage	open emitter		-	-30	V			
V _{CEO}	collector-emitter voltage	open base		-	-30	V			
V _{EBO}	emitter-base voltage	open collector		-	-7	V			
I _C	collector current			-	-1	А			
I _{CM}	peak collector current	single pulse; $t_p \le 1 \text{ ms}$		-	-2	А			
I _B	base current			-	-0.3	А			
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PBSS5130PAP

30 V, 1 A PNP/PNP low VCEsat (BISS) transistor

Symbol	Parameter	Conditions	M	in Max	Unit
I _{BM}	peak base current	single pulse; t _p ≤ 1 ms	-	-1	А
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C	[1] -	370	mW
			[2] -	570	mW
			[3] -	530	mW
			[4] -	700	mW
			[5] -	450	mW
			[6] -	760	mW
			[7] -	700	mW
			[8] -	1450	mW
Per device					
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C	[1] -	510	mW
			[2] -	780	mW
			[3] -	730	mW
			[4] -	960	mW
			[5] -	620	mW
			[6] -	1040	mW
			[7] -	960	mW
			[8] -	2000	mW
Tj	junction temperature		-	150	°C
T _{amb}	ambient temperature			55 150	°C
T _{stg}	storage temperature			65 150	°C

Device mounted on an FR4 PCB, single-sided 35 μm copper strip line, tin-plated and standard footprint.
 Device mounted on an FR4 PCB, single-sided 35 μm copper strip line, tin-plated, mounting pad for collector 1 cm².

[3] Device mounted on 4-layer PCB 35 µm copper strip line, tin-plated and standard footprint.

[4] Device mounted on 4-layer PCB 35 µm copper strip line, tin-plated, mounting pad for collector 1 cm².

[5] Device mounted on an FR4 PCB, single-sided 70 µm copper strip line, tin-plated and standard footprint.

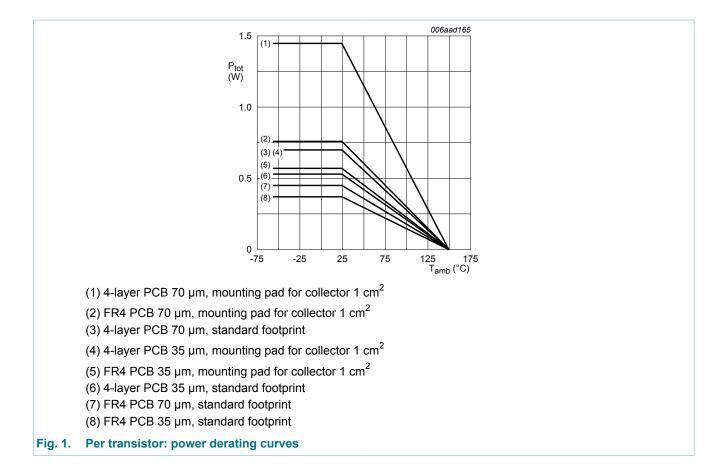
[6] Device mounted on an FR4 PCB, single-sided 70 μm copper strip line, tin-plated, mounting pad for collector 1 cm².

[7] Device mounted on 4-layer PCB 70 µm copper strip line, tin-plated and standard footprint.

[8] Device mounted on 4-layer PCB 70 µm copper strip line, tin-plated, mounting pad for collector 1 cm².

PBSS5130PAP

30 V, 1 A PNP/PNP low VCEsat (BISS) transistor



9. Thermal characteristics

Table 6. T	hermal characteristics						
Symbol	Parameter	Conditions		Min	Тур	Мах	Unit
Per transist	or		· ·				
R _{th(j-a)}	thermal resistance	in free air	[1]	-	-	338	K/W
	from junction to		[2]	-	-	219	K/W
	ambient		[3]	-	-	236	K/W
			[4]	-	-	179	K/W
			[5]	-	-	278	K/W
			[6]	-	-	164	K/W
			[7]	-	-	179	K/W
			[8]	-	-	86	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point			-	-	30	K/W

PBSS5130PAP

30 V, 1 A PNP/PNP low VCEsat (BISS) transistor

Symbol	Parameter	Conditions		Min	Тур	Мах	Unit
Per device							
fron	thermal resistance	in free air	[1]	-	-	245	K/W
	from junction to ambient		[2]	-	-	160	K/W
	ampient		[3]	-	-	171	K/W
			[4]	-	-	130	K/W
			[5]	-	-	202	K/W
			[6]	-	-	120	K/W
			[7]	-	-	130	K/W
			[8]	-	-	63	K/W

Device mounted on an FR4 PCB, single-sided 35 μm copper strip line, tin-plated and standard footprint.
 Device mounted on an FR4 PCB, single-sided 35 μm copper strip line, tin-plated, mounting pad for collector 1 cm².

[3] Device mounted on 4-layer PCB 35 µm copper strip line, tin-plated and standard footprint.

[4] Device mounted on 4-layer PCB 35 µm copper strip line, tin-plated, mounting pad for collector 1 cm².

[5] Device mounted on an FR4 PCB, single-sided 70 µm copper strip line, tin-plated and standard footprint.

[6] Device mounted on an FR4 PCB, single-sided 70 µm copper strip line, tin-plated, mounting pad for collector 1 cm².

[7] Device mounted on 4-layer PCB 70 µm copper strip line, tin-plated and standard footprint.

[8] Device mounted on 4-layer PCB 70 µm copper strip line, tin-plated, mounting pad for collector 1 cm².

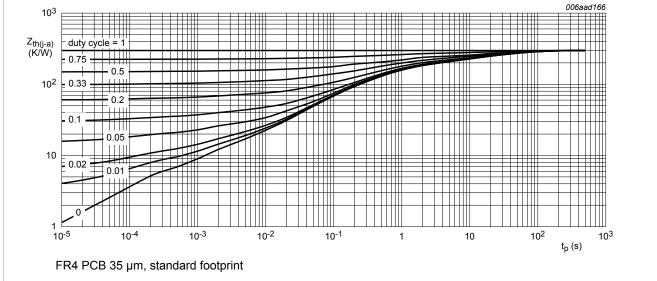
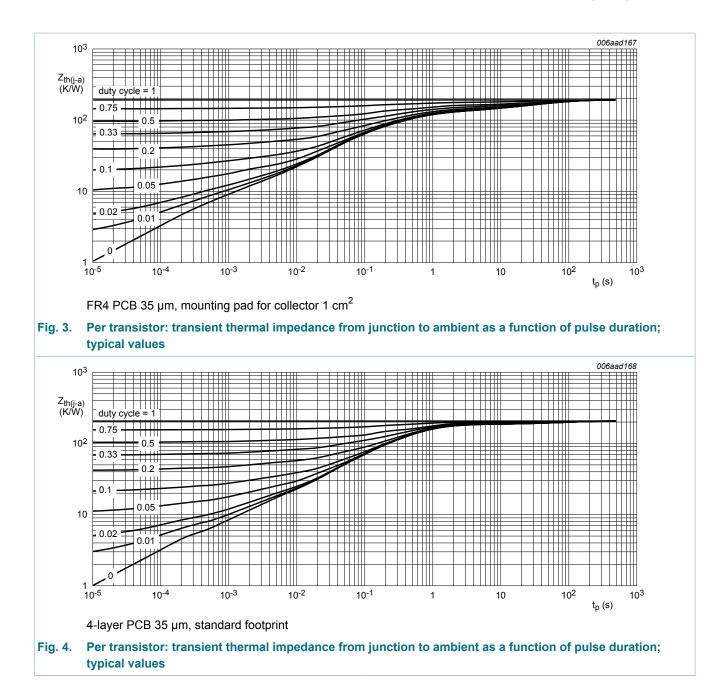


Fig. 2. Per transistor: transient thermal impedance from junction to ambient as a function of pulse duration; typical values

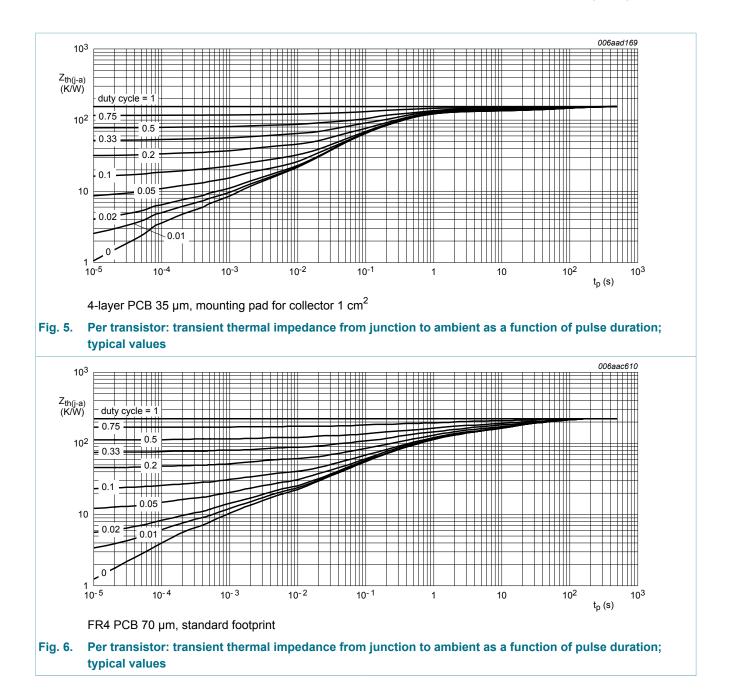
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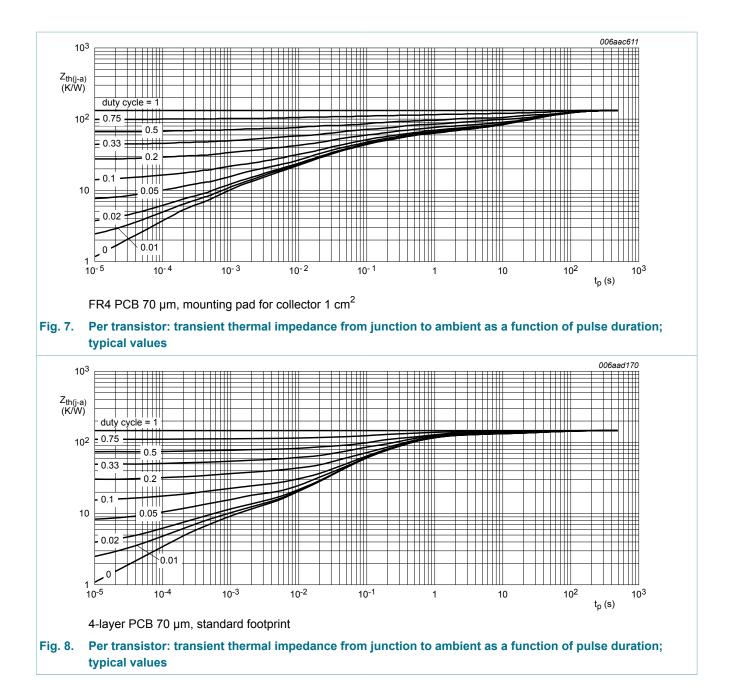
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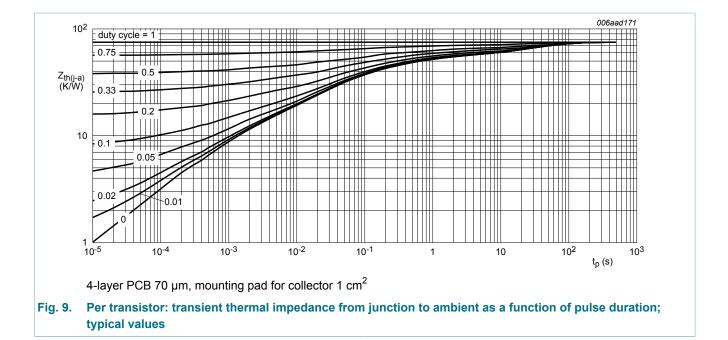
PBSS5130PAP

30 V, 1 A PNP/PNP low VCEsat (BISS) transistor



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30 V, 1 A PNP/PNP low VCEsat (BISS) transistor



10. Characteristics

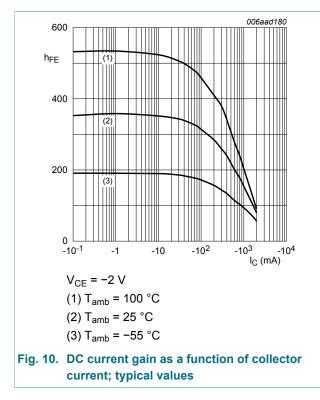
Table 7. Characteristics

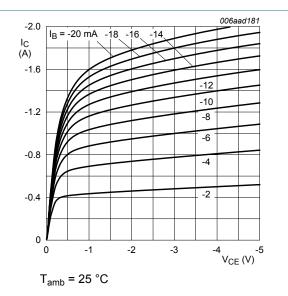
Symbol	Parameter	Conditions	N	lin	Тур	Max	Unit
Per transis	tor						
I _{CBO}	collector-base cut-off	V_{CB} = -24 V; I _E = 0 A; T _{amb} = 25 °C	-		-	-100	nA
	current	V_{CB} = -24 V; I _E = 0 A; T _j = 150 °C	-		-	-50	μA
I _{EBO}	emitter-base cut-off current	V _{EB} = -5 V; I _C = 0 A; T _{amb} = 25 °C	-		-	-100	nA
h _{FE}	DC current gain	$\label{eq:Vce} \begin{array}{l} V_{CE} \texttt{=} \texttt{-2} \; V \texttt{;} \; I_{C} \texttt{=} \texttt{-100} \; mA \texttt{;} \; pulsed \texttt{;} \\ t_{p} \texttt{\leq} \texttt{300} \; \mu \texttt{s} \texttt{;} \; \delta \texttt{\leq} \texttt{0.02} \; \texttt{;} \; T_{amb} \texttt{=} \texttt{25} \; ^{\circ} C \end{array}$	2	250	350	-	
		$ \begin{aligned} &V_{CE} \texttt{= -2 V; } I_{C} \texttt{= -500 mA; pulsed;} \\ &t_{p} \texttt{\leq 300 } \mu\texttt{s}\texttt{; } \delta \texttt{\leq 0.02 ; } T_{amb} \texttt{= 25 °C} \end{aligned} $	1	70	250	-	
		$\label{eq:V_CE} \begin{array}{l} V_{CE} = \text{-2 V; } I_{C} = \text{-1 A; pulsed;} \\ t_{p} \leq 300 \; \mu s; \; \delta \leq 0.02 \; ; \; T_{amb} = 25 \; ^{\circ}C \end{array}$	1	20	175	-	
V _{CEsat}	collector-emitter saturation voltage	I_{C} = -500 mA; I_{B} = -50 mA; pulsed; $t_{p} \le 300 \ \mu$ s; δ ≤ 0.02 ; T_{amb} = 25 °C	-		-85	-140	mV
		I_{C} = -1 A; I_{B} = -50 mA; pulsed; t _p ≤ 300 μs; δ ≤ 0.02 ; T _{amb} = 25 °C	-		-175	-280	mV
		I_{C} = -1 A; I_{B} = -100 mA; pulsed; $t_{p} \le 300 \ \mu$ s; δ ≤ 0.02 ; T_{amb} = 25 °C	-		-160	-250	mV
R _{CEsat}	collector-emitter saturation resistance	I_{C} = -1 A; I_{B} = -0.1 A; pulsed; $t_{p} \le 300 \ \mu s; \delta \le 0.02$; T_{amb} = 25 °C	-		-	250	mΩ

PBSS5130PAP

30 V, 1 A PNP/PNP low VCEsat (BISS) transistor

Symbol	Parameter	Conditions	Mir	і Тур	Max	Unit
V _{BEsat}	base-emitter saturation voltage	I_C = -500 mA; I_B = -50 mA; pulsed; t_p ≤ 300 μs; δ ≤ 0.02 ; T_{amb} = 25 °C	-	-	-1	V
		I _C = -1 A; I _B = -50 mA; T _{amb} = 25 °C	-	-	-1	V
		$\begin{split} I_{C} &= -1 \text{ A}; \text{ I}_{B} = -100 \text{ mA}; \text{ pulsed}; \\ t_{p} &\leq 300 \mu\text{s}; \delta \leq 0.02 \text{ ; } \text{T}_{amb} = 25 ^{\circ}\text{C} \end{split}$	-	-	-1.1	V
V _{BEon}	base-emitter turn-on voltage	$\label{eq:VcE} \begin{array}{l} V_{CE} \texttt{=} \texttt{-2} \; V \texttt{;} \; I_{C} \texttt{=} \texttt{-0.5} \; A \texttt{;} \; \texttt{pulsed} \texttt{;} \\ t_{p} \texttt{\leq} \texttt{300} \; \mu \texttt{s} \texttt{;} \; \overline{o} \texttt{\leq} \texttt{0.02} \texttt{;} \; T_{amb} \texttt{=} \texttt{25} \; ^{\circ} C \end{array}$	-	-	-0.9	V
t _d	delay time	V_{CC} = -10 V; I _C = -0.5 A; I _{Bon} = -25 mA; I _{Boff} = 25 mA; T _{amb} = 25 °C	-	15	-	ns
t _r	rise time		-	35	-	ns
t _{on}	turn-on time		-	50	-	ns
ts	storage time		-	105	-	ns
t _f	fall time		-	35	-	ns
t _{off}	turn-off time		-	140	-	ns
f _T	transition frequency	V_{CE} = -10 V; I _C = -50 mA; f = 100 MHz; T _{amb} = 25 °C	65	125	-	MHz
C _c	collector capacitance	V _{CB} = -10 V; I _E = 0 A; i _e = 0 A; f = 1 MHz; T _{amb} = 25 °C	-	13	17	pF

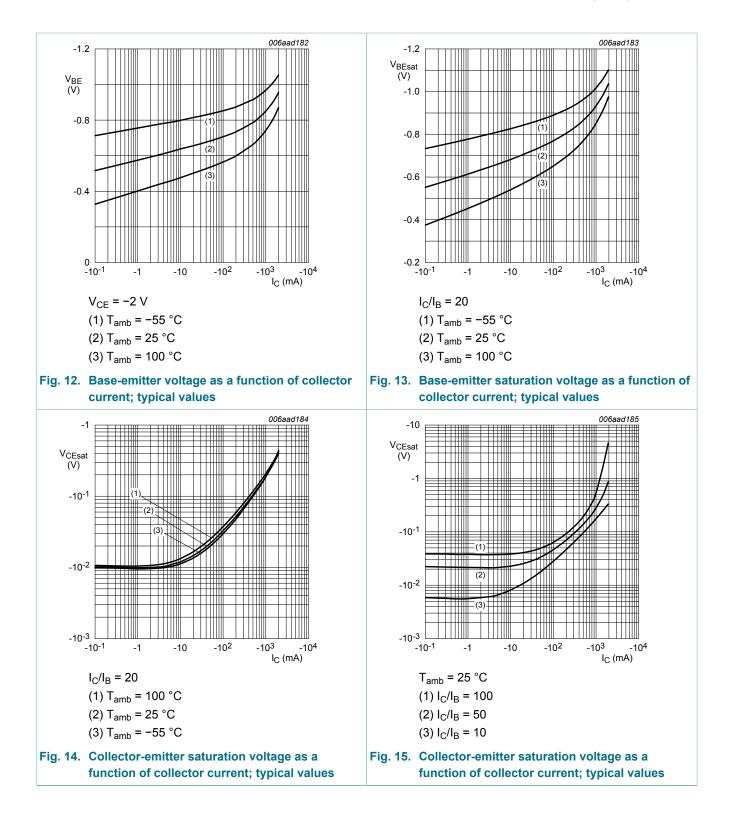






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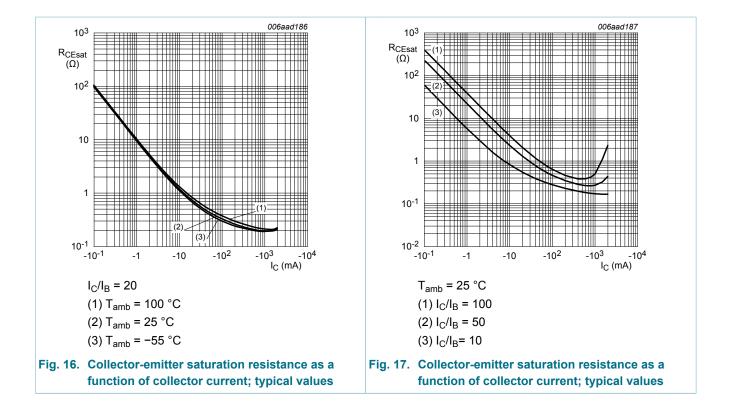
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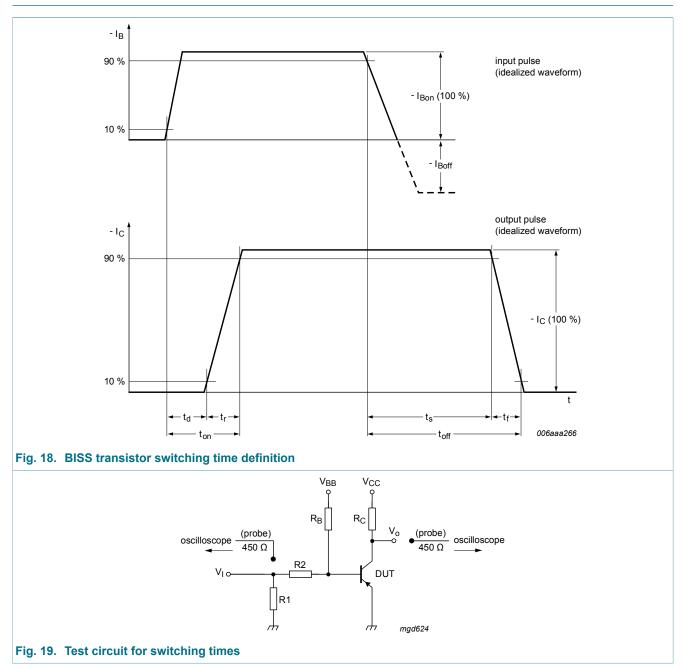
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11. Test information

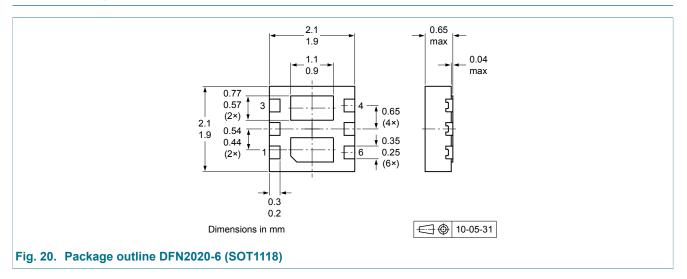


This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101* - *Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

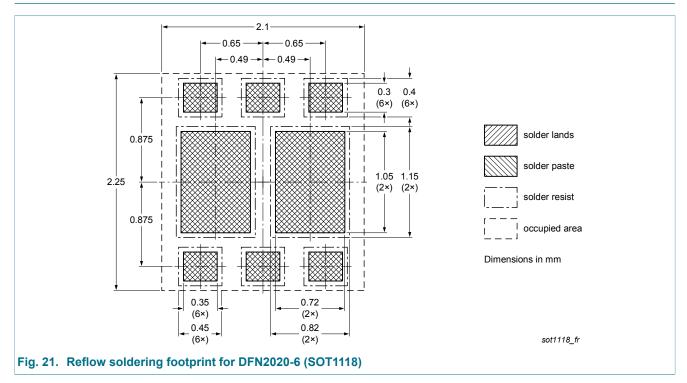
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12. Package outline



13. Soldering



14. Revision history

Table 8. Revision hi	istory			
Data sheet ID	Release date	Data sheet status	Change notice	Supersedes
PBSS5130PAP v.1	20121212	Product data sheet	-	-
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Product data sheet		12 December 2012		14 / 17

30 V, 1 A PNP/PNP low VCEsat (BISS) transistor

15. Legal information

15.1 Data sheet status

Document status [1][2]	Product status [<u>3]</u>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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30 V, 1 A PNP/PNP low VCEsat (BISS) transistor

16. Contents

1	General description1
2	Features and benefits1
3	Applications1
4	Quick reference data1
5	Pinning information2
6	Ordering information2
7	Marking2
8	Limiting values2
9	Thermal characteristics4
10	Characteristics9
11	Test information13
11.1	Quality information
12	Package outline 14
13	Soldering14
14	Revision history14
15	Legal information15
15.1	Data sheet status 15
15.2	Definitions15
15.3	Disclaimers15
15.4	Trademarks16

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